## GCMS020A120B1H1 1200V 20 mohm SiC MOSFET Module



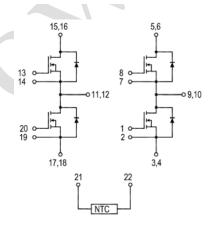
#### Features:

- Ultra Low Loss
- High-Frequency Operation
- Zero Reverse Recovery Current from Diode
- Zero Turn-off Tail Current from MOSFET
- Normally-off, Fail-safe Device Operation
- Easy of Paralleling



- Solar Inverters
- High Voltage DC/DC Converters
- Motor Drives
- EV Chargers
- UPS





### Absolute Maximum Ratings ( $T_C$ =25 $^{\circ}$ C unless otherwise specified)

Symbol		Value	Units	
V <sub>DSmax</sub>	Drain-Source Voltage	1200	V	
V <sub>GSmax</sub>	Gate-Source Voltage	Absolute Maximum values	-10/+25	V
$V_{GSop}$	Gate-Source Voltage	Recommended Operational Values	-5/20	V
	Continuous Drain Current	V <sub>GS</sub> =20V,T <sub>C</sub> =25 <sup>0</sup> C	95	Α
I <sub>D(DC)</sub>	Continuous Dialii Curient	V <sub>GS</sub> =20V,T <sub>C</sub> =100 <sup>0</sup> C	80	Α
I <sub>D(pluse)</sub>	Pulsed Drain Current	Pulse width t <sub>p</sub> limited by T <sub>jmax</sub>	160	Α
P <sub>D</sub>	Power Dissipation	$T_c=25^{\circ}C, T_j=150^{\circ}C$	305	W

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### **Electrical Characteristics of MOSFET** (T<sub>C</sub>=25°C unless otherwise specified)

Symbol	Description	Conditions		Min	Тур	Max	Unit	
V <sub>(BR)DSS</sub>	Drain - Source Breakdown Voltage	V <sub>GS</sub> =0V,I <sub>D</sub> =100uA		1.2			KV	
		$V_{DS}$ = 10 V, $I_{D}$ =20 mA, $T_{j}$ =25 $^{0}$ C			2.9			
V <sub>GS(th) (chip)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = 10 V, I <sub>D</sub> =20 mA, T <sub>j</sub> =125 <sup>0</sup> C			2.4	P	V	
		V <sub>DS</sub> = 10 V, I <sub>D</sub> =2	0 mA, T <sub>j</sub> =150 <sup>0</sup> C		2.3			
		V <sub>DS</sub> = 10 V, I <sub>D</sub> =4	mA, T <sub>j</sub> =25 <sup>0</sup> C		2.9	) >	,	
V <sub>GS(th)</sub> (terminal)	Gate Threshold Voltage	V <sub>DS</sub> = 10 V, I <sub>D</sub> =4	mA, T <sub>j</sub> =125 <sup>0</sup> C	1	2.2		V	
		V <sub>DS</sub> = 10 V, I <sub>D</sub> =4	mA, T <sub>j</sub> =150 <sup>0</sup> C		2.1			
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 1.2 kV, V <sub>GS</sub>	<sub>3</sub> = 0V	7		1	mA	
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> = 20 V, V <sub>DS</sub> =	= 0V			400	nA	
В	On State Registeres	V <sub>GS</sub> = 20 V, I <sub>DS</sub> =	80 A, T <sub>J</sub> = 25°C		20			
R <sub>DS(on) (chip)</sub>	On State Resistance	V <sub>GS</sub> = 20 V, I <sub>DS</sub> =80 A, T <sub>J</sub> = 150°C			42		mΩ	
		V <sub>GS</sub> = 20 V, I <sub>DS</sub> =	80 A, T <sub>J</sub> = 25°C		20			
R <sub>DS(on) (terminal)</sub>	On State Resistance	V <sub>GS</sub> = 20 V, I <sub>DS</sub> = 80 A, T <sub>J</sub> = 125°C			28		mΩ	
	6	$V_{GS} = 20 \text{ V}, I_{DS} = 80 \text{ A}, T_{J} = 150^{\circ}\text{C}$			32			
a.	Transconductance	$V_{DS}$ = 20 V, $I_{DS}$ = 80 A, Tj=25 $^{\circ}$ C			30.2		S	
<b>g</b> fs		$V_{DS}$ = 20 V, $I_{DS}$ = 80 A, Tj=150 $^{0}$ C			26.4		S	
C <sub>iss(chip)</sub>	Input Capacitance				3786		nF	
C <sub>oss(chip)</sub>	Output Capacitance	$V_{DS} = 1000V, f = V_{AC} = 25 \text{ mV}$	1MHz,		300			
C <sub>rss(chip)</sub>	Reverse Transfer Capacitance				20			
	7		Tj=25 <sup>0</sup> C		1.0			
E <sub>on</sub>	Turn-On Switching Energy		Tj=125 <sup>0</sup> C		1.5			
		$V_{DD} = 600 \text{ V},$ $V_{GS} = -5\text{V}/+20\text{V}$	Tj=150 <sup>0</sup> C		1.6		mJ	
$E_{off}$	Turn-Off Switching Energy	$I_D = 80 \text{ A},$ $R_{G(ext)} = 20 \Omega$	Tj=25 <sup>0</sup> C		0.3		1113	
			Tj=125 <sup>0</sup> C		0.6			
			Tj=150 <sup>0</sup> C		0.8			
R <sub>G(int)</sub>	Internal Gate Resistance	f =1MHz, V <sub>AC</sub> = 25 mV			0.9		Ω	

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Q <sub>GS</sub>	Gate-Source Charge				56	
Q <sub>GD</sub>	Gate-Drain Chrage		$V_{DD}$ = 800 V, $V_{GS}$ = -5V/+20V, $I_{D}$ = 80 A,		74	nC
Q <sub>G</sub>	Total Gate Chrage				230	1
			Tj=25 <sup>0</sup> C		104	
$t_{d(on)}$	Turn-on delay time		Tj=125 <sup>0</sup> C		98	
			Tj=150 <sup>0</sup> C		96	
	Rise Time		Tj=25 <sup>0</sup> C		63	
t <sub>r</sub>		$V_{DD} = 600V, \\ V_{GS} = -5/+20V, \\ I_{D} = 80 \text{ A}, \\ R_{G(ext)} = 20 \Omega, \\ Timing relative $ $Tj=125^{0}C$ $Tj=150^{0}C$ $Tj=25^{0}C$	Tj=125 <sup>0</sup> C	4	56	
				57	ns	
			Tj=25°C		181	
$t_{\text{d(off)}} \\$	Turn-off delay time	to V <sub>DS</sub>	Tj=125 <sup>0</sup> C		216	
			Tj=150 <sup>0</sup> C		220	
			Tj=25 <sup>0</sup> C		94	
t <sub>f</sub>	Fall Time	AX	Tj=125 <sup>0</sup> C		99	
			Tj=150°C		99	
R <sub>0</sub> JCM	Thermal Resistance Junction To-Case for MOSFET				0.41	°C /W

## **Built-in SiC Body Diode Characteristics** (T<sub>C</sub>=25<sup>o</sup>C unless otherwise specified)

Symbol	Description	Conditions	Min	Тур	Max	Unit
\/	Diada Faruard Valtaga	$I_{SD}$ = 40 A, $V_{GS}$ = -5V , $T_j$ =25 $^{0}$ C		3.6		\/
V <sub>SD(chip)</sub>	Diode Forward Voltage	$I_{SD} = 40 \text{ A}, V_{GS} = -5V, T_j = 150^{\circ}\text{C}$		3.3		V
T <sub>rr</sub>	Reverse Recovery Time	L = 90 A \/ = 5\/		108		ns
Qrr	Reverse Recovery Charge	$I_{SD}$ = 80 A, $V_{GS}$ = -5V , $T_{j}$ =25 $^{\circ}$ C, $V_{R}$ =800V, $di_{F}/dt$ = 2200 A/ $\mu$ s		566		nC
I <sub>rrm</sub>	Peak Reverse Recovery Current	- aiprat - 2200 / v p3		30		Α

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### Free-Wheeling SiC Diode Characteristics (T<sub>C</sub>=25 °C unless otherwise specified)

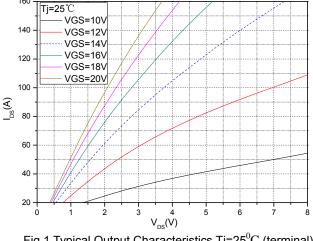
Symbol	Description	Conditions	Min	Тур	Max	Unit
		$I_F = 80 \text{ A}, V_{GS} = 0 \text{ V}, T_j = 25^{\circ}\text{C}$		2.5		
V <sub>F(terminal)</sub>	Diode Forward Voltage	I <sub>F</sub> = 80 A, V <sub>GS</sub> = 0 V ,T <sub>j</sub> =125 <sup>0</sup> C		2.9		V
		$I_F = 80 \text{ A}, V_{GS} = 0 \text{ V}, T_j = 150^{\circ}\text{C}$		3.0	P	
Q <sub>C</sub>	Total Capacitive Charge	V <sub>R</sub> = 1200 V, T <sub>J</sub> = 27°C		129		nC
R <sub>θJC</sub>	Diode Thermal Resistance: Junction-To-Case			1.21	) 7	°C /W
		$T_{C}=25^{\circ}C$ , $T_{j}=175^{\circ}C$	. 1	94		
I <sub>F(chip)</sub>	Continuous Diode Forward Current	T <sub>C</sub> =125 <sup>o</sup> C, T <sub>j</sub> =175 <sup>o</sup> C		52		Α
		$T_C=150^{\circ}C, T_j=175^{\circ}C$		35		

### **Module**

Symbol	Description		Тур	Max	Unit
V <sub>iso</sub>	Isolation Voltage(All Terminals Shorted) f = 50Hz, 1minute	2500			V
TJ	Maximum Junction Temperature			150	$^{\circ}$ C
T <sub>JOP</sub>	Maximum Operating Junction Temperature Range	-40		+150	$^{\circ}\!\mathbb{C}$
$T_{stg}$	Storage Temperature	-40		+125	°C
R <sub>ecs</sub>	Case-To-Sink (Conductive Grease Applied)		0.1		°C/W
Т	Mounting Screw:M6			1.5	N·m
G	Weight		25		g

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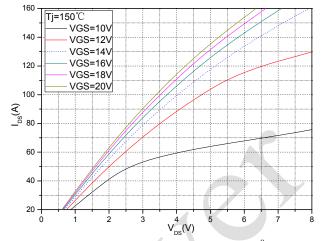
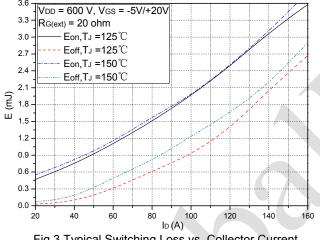


Fig.1 Typical Output Characteristics Tj=25<sup>o</sup>C (terminal)

Fig.2 Typical Output Characteristics Tj=150<sup>o</sup>C (terminal)



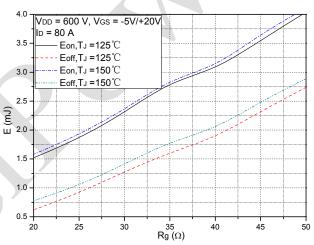
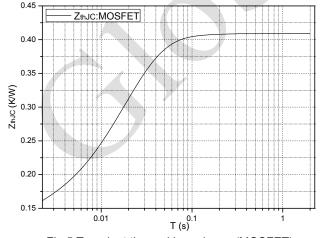


Fig.3 Typical Switching Loss vs. Collector Current

Fig.4 Typical Switching Loss vs. Gate Resistance



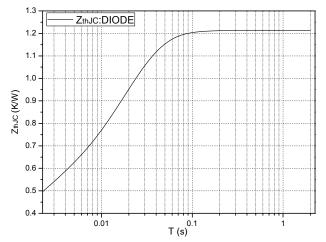


Fig.5 Transient thermal impedance (MOSFET)

Fig.6 Transient thermal impedance (Free-Wheeling SiC Diode)

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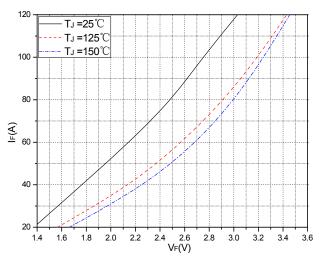


Fig.7 Forward Characteristics of Diode

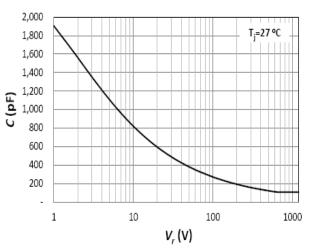


Fig.8 Capacitance (Free-Wheeling SiC Diode)

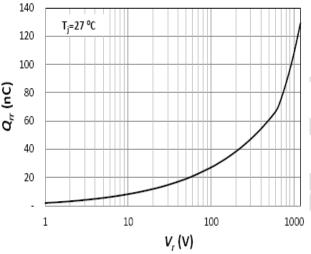


Fig.9 Recovery Charge (Free-Wheeling SiC Diode)

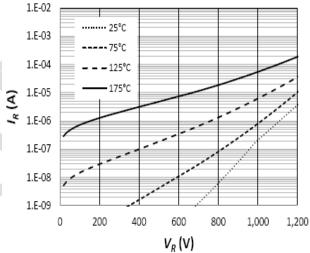
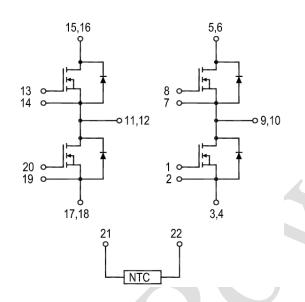


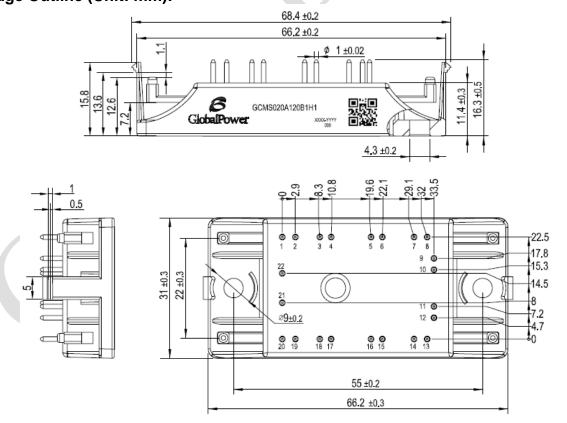
Fig.10 Reverse Characteristics (Free-Wheeling SiC Diode)

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### **Internal Circuit**



### Package Outline (Unit: mm):



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**Revision History** 

Date	Revision	Notes
5/29/2015	0.1	Initial release of preliminary datasheet
4/15/2016	0.2	Add the test data and revised package drawing

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#### **Notes**

#### RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented March, 2013. RoHS Declarations for this product can be obtained from the Product Documentation sections of www.gptechgroup.com.

#### • REACh Compliance

REACh substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact our office at GPTG Headquarters in Lake Forest, California to insure you get the most up-to-date REACh SVHC Declaration.

REACh banned substance information (REACh Article 67) is also available upon request.

- This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, or air traffic control.
- To obtain additional technical information or to place an order for this product, please contact
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